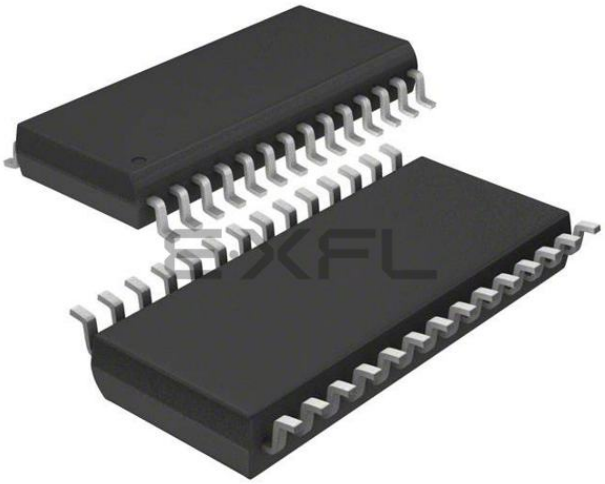

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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	M8C
Core Size	8-Bit
Speed	12MHz
Connectivity	I²C, SPI
Peripherals	LVD, POR, WDT
Number of I/O	24
Program Memory Size	8KB (8K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	512 x 8
Voltage - Supply (Vcc/Vdd)	2.4V ~ 5.25V
Data Converters	-
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	28-SSOP (0.209", 5.30mm Width)
Supplier Device Package	28-SSOP
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/cy8c20534-12pvxi

Contents

PSoC Functional Overview

The PSoC family consists of many *Programmable System-on-Chips with On-Chip Controller* devices. These devices are designed to replace multiple traditional MCU based system components with one low cost single chip programmable component. A PSoC device includes configurable analog and digital blocks and programmable interconnect. This architecture enables the user to create customized peripheral configurations to match the requirements of each individual application. Additionally, a fast CPU, flash program memory, SRAM data memory, and configurable I/O are included in a range of convenient pinouts.

The PSoC architecture for this device family, as shown in Figure 2, consists of three main areas: the Core, the System Resources, and the CapSense Analog System. A common versatile bus enables connection between I/O and the analog system. Each CY8C20x34 PSoC device includes a dedicated CapSense block that provides sensing and scanning control circuitry for capacitive sensing applications. Depending on the PSoC package, up to 28 general purpose I/O (GPIO) are also included. The GPIO provide access to the MCU and analog mux.

PSoC Core

The PSoC Core is a powerful engine that supports a rich instruction set. It encompasses SRAM for data storage, an interrupt controller, sleep and watchdog timers, IMO, and ILO. The CPU core, called the M8C, is a powerful processor with speeds up to 12 MHz. The M8C is a two MIPS, 8-bit Harvard-architecture microprocessor.

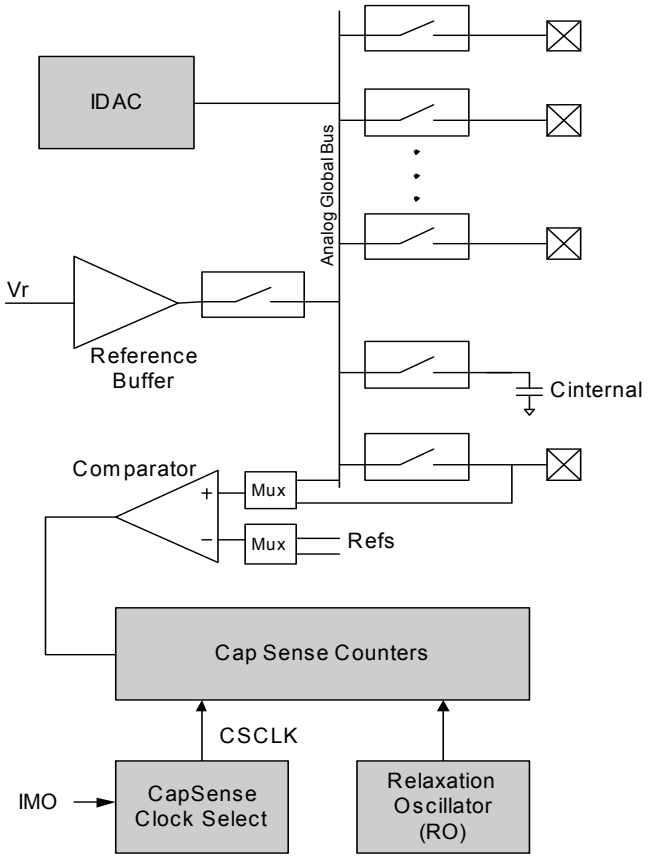
System Resources provide additional capability such as a configurable I^2C slave or SPI master-slave communication interface and various system resets supported by the M8C.

The Analog System consists of the CapSense PSoC block and an internal 1.8 V analog reference. Together they support capacitive sensing of up to 28 inputs.

CapSense Analog System

The Analog System contains the capacitive sensing hardware. Several hardware algorithms are supported. This hardware performs capacitive sensing and scanning without requiring external components. Capacitive sensing is configurable on each GPIO pin. Scanning of enabled CapSense pins is completed quickly and easily across multiple ports.

Figure 2. Analog System Block Diagram



Analog Multiplexer System

The Analog Mux Bus connects to every GPIO pin. Pins are connected to the bus individually or in any combination. The bus also connects to the analog system for analysis with the CapSense block comparator.

Switch control logic enables selected pins to precharge continuously under hardware control. This enables capacitive measurement for applications such as touch sensing. Other multiplexer applications include:

- Complex capacitive sensing interfaces such as sliders and touch pads
- Chip-wide mux that enables analog input from any I/O pin
- Crosspoint connection between any I/O pin combinations

Additional System Resources

System Resources provide additional capability useful to complete systems. Additional resources include low voltage detection and power on reset. Brief statements describing the merits of each system resource follow:

- The I^2C slave or SPI master-slave module provides 50/100/400 kHz communication over two wires. SPI communication over three or four wires run at speeds of 46.9 kHz to 3 MHz (lower for a slower system clock).
- Low voltage detection (LVD) interrupts signal the application of falling voltage levels, while the advanced POR (Power On Reset) circuit eliminates the need for a system supervisor.
- An internal 1.8 V reference provides an absolute reference for capacitive sensing.
- The 5 V maximum input, 3 V fixed output, low dropout regulator (LDO) provides regulation for I/Os. A register controlled bypass mode enables the user to disable the LDO.

PSoC Device Characteristics

Depending on your PSoC device characteristics, the digital and analog systems can have 16, 8, or 4 digital blocks, and 12, 6, or 4 analog blocks. Table 1 lists the resources available for specific PSoC device groups. The PSoC device covered by this datasheet is highlighted.

Table 1. PSoC Device Characteristics

PSoC Part Number	Digital I/O	Digital Rows	Digital Blocks	Analog Inputs	Analog Outputs	Analog Columns	Analog Blocks	SRAM Size	Flash Size
CY8C29x66	up to 64	4	16	up to 12	4	4	12	2 K	32 K
CY8C28xxx	up to 44	up to 3	up to 12	up to 44	up to 4	up to 6	up to 12 + 4[1]	1 K	16 K
CY8C27x43	up to 44	2	8	up to 12	4	4	12	256	16 K
CY8C24x94	up to 56	1	4	up to 48	2	2	6	1 K	16 K
CY8C24x23A	up to 24	1	4	up to 12	2	2	6	256	4 K
CY8C23x33	up to 26	1	4	up to 12	2	2	4	256	8 K
CY8C22x45	up to 38	2	8	up to 38	0	4	6[1]	1 K	16 K
CY8C21x45	up to 24	1	4	up to 24	0	4	6[1]	512	8 K
CY8C21x34	up to 28	1	4	up to 28	0	2	4[1]	512	8 K
CY8C21x23	up to 16	1	4	up to 8	0	2	4[1]	256	4 K
CY8C20x34	up to 28	0	0	up to 28	0	0	3[1,2]	512	8 K
CY8C20xx6	up to 36	0	0	up to 36	0	0	3[1,2]	up to 2 K	up to 32 K

Notes
1. Limited analog functionality
2. Two analog blocks and one CapSense®.

Getting Started

For in-depth information, along with detailed programming details, see the *PSoC® Technical Reference Manual*.

For up-to-date ordering, packaging, and electrical specification information, see the latest PSoC device datasheets on the web.

Application Notes

Cypress application notes are an excellent introduction to the wide variety of possible PSoC designs.

Development Kits

PSoC Development Kits are available online from and through a growing number of regional and global distributors, which include Arrow, Avnet, Digi-Key, Farnell, Future Electronics, and Newark.

Training

Free PSoC technical training (on demand, webinars, and workshops), which is available online via www.cypress.com, covers a wide variety of topics and skill levels to assist you in your designs.

CYPros Consultants

Certified PSoC consultants offer everything from technical assistance to completed PSoC designs. To contact or become a PSoC consultant go to the CYPros Consultants web site.

Solutions Library

Visit our growing library of solution focused designs. Here you can find various application designs that include firmware and hardware design files that enable you to complete your designs quickly.

Technical Support

Technical support – including a searchable Knowledge Base articles and technical forums – is also available online. If you cannot find an answer to your question, call our Technical Support hotline at 1-800-541-4736.

Development Tools

PSoC Designer™ is the revolutionary integrated design environment (IDE) that you can use to customize PSoC to meet your specific application requirements. PSoC Designer software accelerates system design and time to market. Develop your applications using a library of precharacterized analog and digital peripherals (called user modules) in a drag-and-drop design environment. Then, customize your design by leveraging the dynamically generated application programming interface (API) libraries of code. Finally, debug and test your designs with the integrated debug environment, including in-circuit emulation and standard software debug features. PSoC Designer includes:

- Application editor graphical user interface (GUI) for device and user module configuration and dynamic reconfiguration
- Extensive user module catalog
- Integrated source-code editor (C and assembly)
- Free C compiler with no size restrictions or time limits
- Built-in debugger
- In-circuit emulation
- Built-in support for communication interfaces:
  - Hardware and software I^2C slaves and masters
  - Full-speed USB 2.0
  - Up to four full-duplex universal asynchronous receiver/transmitters (UARTs), SPI master and slave, and wireless

PSoC Designer supports the entire library of PSoC 1 devices and runs on Windows XP, Windows Vista, and Windows 7.

PSoC Designer Software Subsystems

Design Entry

In the chip-level view, choose a base device to work with. Then select different onboard analog and digital components that use the PSoC blocks, which are called user modules. Examples of user modules are ADCs, DACs, amplifiers, and filters. Configure the user modules for your chosen application and connect them to each other and to the proper pins. Then generate your project. This prepopulates your project with APIs and libraries that you can use to program your application.

The tool also supports easy development of multiple configurations and dynamic reconfiguration. Dynamic reconfiguration makes it possible to change configurations at run time. In essence, this allows you to use more than 100 percent of PSoC's resources for an application.

Code Generation Tools

The code generation tools work seamlessly within the PSoC Designer interface and have been tested with a full range of debugging tools. You can develop your design in C, assembly, or a combination of the two.

Assemblers. The assemblers allow you to merge assembly code seamlessly with C code. Link libraries automatically use absolute addressing or are compiled in relative mode, and are linked with other software modules to get absolute addressing.

C Language Compilers. C language compilers are available that support the PSoC family of devices. The products allow you to create complete C programs for the PSoC family devices. The optimizing C compilers provide all of the features of C, tailored to the PSoC architecture. They come complete with embedded libraries providing port and bus operations, standard keypad and display support, and extended math functionality.

Debugger

PSoC Designer has a debug environment that provides hardware in-circuit emulation, allowing you to test the program in a physical system while providing an internal view of the PSoC device. Debugger commands allow you to read and program and read and write data memory, and read and write I/O registers. You can read and write CPU registers, set and clear breakpoints, and provide program run, halt, and step control. The debugger also allows you to create a trace buffer of registers and memory locations of interest.

Online Help System

The online help system displays online, context-sensitive help. Designed for procedural and quick reference, each functional subsystem has its own context-sensitive help. This system also provides tutorials and links to FAQs and an online support Forum to aid the designer.

In-Circuit Emulator

A low-cost, high-functionality in-circuit emulator (ICE) is available for development support. This hardware can program single devices.

The emulator consists of a base unit that connects to the PC using a USB port. The base unit is universal and operates with all PSoC devices. Emulation pods for each device family are available separately. The emulation pod takes the place of the PSoC device in the target board and performs full-speed (24 MHz) operation.

16-Pin SOIC Pinout

Figure 4. CY8C20234-12SXI 16-Pin SOIC Pinout

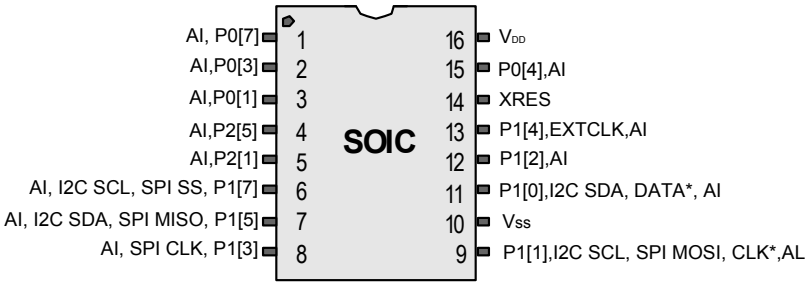


Table 3. Pin Definitions – CY8C20234 16-Pin (SOIC)

Pin No.	Digital	Analog	Name	Description
1	I/O	I	P0[7]	Analog column mux input
2	I/O	I	P0[3]	Analog column mux input and column input, integrating input
3	I/O	I	P0[1]	Analog column mux input, integrating input
4	I/O	I	P2[5]	Analog column mux input
5	I/O	I	P2[1]	Analog column mux input
6	I/O	I	P1[7]	I2C serial clock (SCL), SPI SS
7	I/O	I	P1[5]	I2C serial data (SDA),SPI MISO
8	I/O	I	P1[3]	Analog column mux input, SPI CLK
9	I/O	I	P1[1]	I2C serial clock (SCL), ISSP-SCLK,SPI MOSI
10	Power		V_{SS}	Ground connection
11	I/O	I	P1[0]	I2C serial data (SDA), ISSP-SDATA
12	I/O	I	P1[2]	Analog column mux input
13	I/O	I	P1[4]	Analog column mux input, optional external clock input (EXTCLK)
14	I/O	I	XRES	XRES
15	I/O	I	P0[4]	Analog column mux input
16	Power		V_{DD}	Supply voltage

A = Analog, I = Input, O = Output, OH = 5 mA High Output Drive.

Table 4. Pin Definitions – CY8C20000 48-Pin OCD (QFN) [3]

Pin No.	Digital	Analog	Name	Description
18	Power		V_{SS}	OCD CPU clock output
19			CCLK	OCD high speed clock output
20			HCLK	DATA[5], I^2C SDA
21	I_{OH}	I	P1[0]	
22	I_{OH}	I	P1[2]	No connection
23			NC	No connection
24			NC	No connection
25			NC	Optional external clock input (EXTCLK)
26	I_{OH}	I	P1[4]	
27	I_{OH}	I	P1[6]	Active high external reset with internal pull-down
28	Input		XRES	
29	I/O	I	P3[0]	
30	I/O	I	P3[2]	
31	I/O	I	P2[0]	
32	I/O	I	P2[2]	
33	I/O	I	P2[4]	
34	I/O	I	P2[6]	
35	I/O	I	P0[0]	
36	I/O	I	P0[2]	
37			NC	No connection
38			NC	No connection
39			NC	No connection
40	I/O	I	P0[6]	Analog bypass
41	Power		V_{DD}	Supply voltage
42			OCDO	OCD odd data output
43			OCDE	OCD even data I/O
44	I/O	I	P0[7]	
45	I/O	I	P0[5]	
46	I/O	I	P0[3]	Integrating Input
47	Power		V_{SS}	Ground connection
48			NC	No connection
CP	Power		V_{SS}	Center pad is connected to ground

A = Analog, I = Input, O = Output, NC = No Connection H = 5 mA High Output Drive.

Note
5. These are the ISSP pins, that are not High Z at POR (Power-on-Reset). See the *PSoC Technical Reference Manual* for details.

28-Pin Part Pinout

Figure 9. CY8C20534 28-Pin PSoC Device

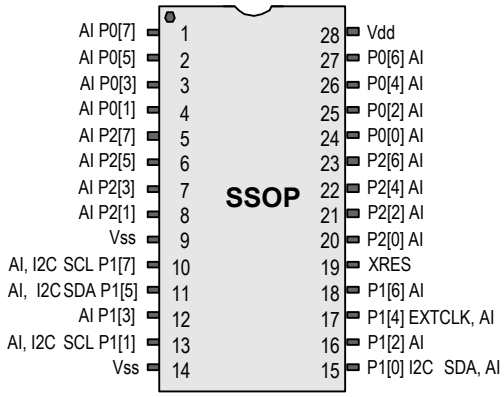


Table 8. Pin Definitions – CY8C20534 28-Pin (SSOP)

Pin No.	Type		Name	Description
	Digital	Analog		
1	I/O	I	P0[7]	Analog column mux input
2	I/O	I	P0[5]	Analog column mux input and column output
3	I/O	I	P0[3]	Analog column mux input and column output, integrating input
4	I/O	I	P0[1]	Analog column mux input, integrating input
5	I/O	I	P2[7]	
6	I/O	I	P2[5]	
7	I/O	I	P2[3]	Direct switched capacitor block input
8	I/O	I	P2[1]	Direct switched capacitor block input
9	Power		V_{SS}	Ground connection[13]
10	I/O	I	P1[7]	I2C serial clock (SCL)
11	I/O	I	P1[5]	I2C serial data (SDA)
12	I/O	I	P1[3]	
13	I/O	I	P1[1]	I2C serial clock (SCL), ISSP-SCLK[14]
14	Power		V_{SS}	Ground connection
15	I/O	I	P1[0]	I2C serial data (SDA), ISSP-SDATA[14]
16	I/O	I	P1[2]	
17	I/O	I	P1[4]	Optional external clock input (EXTCLK)
18	I/O	I	P1[6]	
19	Input		XRES	Active high external reset with internal pull-down
20	I/O	I	P2[0]	Direct switched capacitor block input
21	I/O	I	P2[2]	Direct switched capacitor block input
22	I/O	I	P2[4]	
23	I/O	I	P2[6]	
24	I/O	I	P0[0]	Analog column mux input
25	I/O	I	P0[2]	Analog column mux input
26	I/O	I	P0[4]	Analog column mux input
27	I/O	I	P0[6]	Analog column mux input
28	Power		V_{DD}	Supply voltage

A = Analog, I = Input, O = Output, OH = 5 mA High Output Drive.

Notes
13. All V_{SS} pins should be brought out to one common GND plane.
14. These are the ISSP pins, that are not High Z at POR (Power-on-Reset). See the *PSoC Technical Reference Manual* for details.

Operating Temperature

Table 11. Operating Temperature

Symbol	Description	Min	Typ	Max	Units	Notes
T_A	Ambient temperature	–40	–	+85	°C	
T_J	Junction temperature	–40	–	+100	°C	The temperature rise from ambient to junction is package specific. See Table 16 on page 23. The user must limit the power consumption to comply with this requirement.

DC Electrical Characteristics

DC Chip Level Specifications

Table 12 lists the guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and –40 °C ≤ T_A ≤ 85 °C, 3.0V to 3.6V and –40 °C ≤ T_A ≤ 85 °C, or 2.4 V to 3.0 V and –40 °C ≤ T_A ≤ 85 °C, respectively. Typical parameters apply to 5 V, 3.3 V, or 2.7 V at 25 °C. These are for design guidance only.

Table 12. DC Chip Level Specifications

Symbol	Description	Min	Typ	Max	Units	Notes
V_{DD}	Supply voltage	2.40	–	5.25	V	See Table 16 on page 23.
I_{DD12}	Supply current, IMO = 12 MHz	–	1.5	2.5	mA	Conditions are V_{DD} = 3.0 V, T_A = 25 °C, CPU = 12 MHz.
I_{DD6}	Supply current, IMO = 6 MHz	–	1	1.5	mA	Conditions are V_{DD} = 3.0 V, T_A = 25 °C, CPU = 6 MHz
I_{SB27}	Sleep (mode) current with POR, LVD, Sleep timer, WDT, and internal slow oscillator active. Mid temperature range.	–	2.6	4	µA	V_{DD} = 2.55 V, 0 °C ≤ T_A ≤ 40 °C
I_{SB}	Sleep (mode) current with POR, LVD, Sleep timer, WDT, and internal slow oscillator active.	–	2.8	5	µA	V_{DD} = 3.3 V, –40 °C ≤ T_A ≤ 85 °C

DC GPIO Specifications

Unless otherwise noted, Table 13 lists the guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and –40 °C ≤ T_A ≤ 85 °C, 3.0 V to 3.6 V and –40 °C ≤ T_A ≤ 85 °C, or Table 14 for 2.4 V to 3.0 V and –40 °C ≤ T_A ≤ 85 °C, respectively. Typical parameters apply to 5 V, 3.3 V, and 2.7 V at 25 °C. These are for design guidance only.

Table 13. 5-V and 3.3-V DC GPIO Specifications

Symbol	Description	Min	Typ	Max	Units	Notes
R_{PU}	Pull-up resistor	4	5.6	8	kΩ	
V_{OH1}	High output voltage Port 0, 2, or 3 pins	V_{DD} – 0.2	–	–	V	I_{OH} ≤ 10 µA, V_{DD} ≥ 3.0 V, maximum of 20 mA source current in all I/Os.
V_{OH2}	High output voltage Port 0, 2, or 3 pins	V_{DD} – 0.9	–	–	V	I_{OH} = 1 mA, V_{DD} ≥ 3.0 V, maximum of 20 mA source current in all I/Os.
V_{OH3}	High output voltage Port 1 pins with LDO regulator disabled	V_{DD} – 0.2	–	–	V	I_{OH} < 10 µA, V_{DD} ≥ 3.0 V, maximum of 10 mA source current in all I/Os.
V_{OH4}	High output voltage Port 1 pins with LDO regulator disabled	V_{DD} – 0.9	–	–	V	I_{OH} = 5 mA, V_{DD} ≥ 3.0 V, maximum of 20 mA source current in all I/Os.
V_{OH5}	High output voltage Port 1 pins with 3.0 V LDO regulator enabled	2.7	3.0	3.3	V	I_{OH} < 10 µA, V_{DD} ≥ 3.1 V, maximum of 4 I/Os all sourcing 5 mA.
V_{OH6}	High output voltage Port 1 pins with 3.0 V LDO regulator enabled	2.2	–	–	V	I_{OH} = 5 mA, V_{DD} ≥ 3.1 V, maximum of 20 mA source current in all I/Os.

Table 13. 5-V and 3.3-V DC GPIO Specifications

Symbol	Description	Min	Typ	Max	Units	Notes
V_{OH7}	High output voltage Port 1 pins with 2.4 V LDO regulator enabled	2.1	2.4	2.7	V	I_{OH} < 10 µA, $V_{DD} \geq$ 3.0 V , maximum of 20 mA source current in all I/Os.
V_{OH8}	High output voltage Port 1 pins with 2.4 V LDO regulator enabled	2.0	–	–	V	I_{OH} < 200 µA, $V_{DD} \geq$ 3.0 V, maximum of 20 mA source current in all I/Os.
V_{OH9}	High output voltage Port 1 pins with 1.8 V LDO regulator enabled	1.6	1.8	2.0	V	I_{OH} < 10 µA 3.0V ≤ V_{DD} ≤ 3.6 V 0 °C ≤ T_A ≤ 85 °C Maximum of 20 mA source current in all I/Os.
V_{OH10}	High output voltage Port 1 pins with 1.8 V LDO regulator enabled	1.5	–	–	V	I_{OH} < 100 µA. 3.0V ≤ V_{DD} ≤ 3.6 V. 0 °C ≤ T_A ≤ 85 °C. Maximum of 20 mA source current in all I/Os.
V_{OL}	Low output voltage	–	–	0.75	V	I_{OL} = 20 mA, V_{DD} > 3.0 V, maximum of 60 mA sink current on even port pins (for example, P0[2] and P1[4]) and 60 mA sink current on odd port pins (for example, P0[3] and P1[5]).
I_{OH}	High level source current	–	–	20	mA	V_{OH} = V_{DD} – 0.9. See the limitations of the total current in the Notes for V_{OH}.
I_{OH2}	High level source current port 0, 2, or 3 pins	1	–	–	mA	V_{OH} = V_{DD} – 0.9, for the limitations of the total current and I_{OH} at other V_{OH} levels, see the Notes for V_{OH}.
I_{OH4}	High level source current port 1 Pins with LDO regulator disabled	5	–	–	mA	V_{OH} = V_{DD} – 0.9, for the limitations of the total current and I_{OH} at other V_{OH} levels, see the Notes for V_{OH}.
I_{OL}	Low level sink current	20	–	–	mA	V_{OL} = 0.75 V, see the limitations of the total current in the Notes for V_{OL}
V_{IL}	Input low voltage	–	–	0.8	V	3.6 V ≤ V_{DD} ≤ 5.25 V
V_{IH}	Input high voltage	2.0	–	–	V	3.6 V ≤ V_{DD} ≤ 5.25 V
V_H	Input hysteresis voltage	–	140	–	mV	
I_{IL}	Input leakage (absolute value)	–	1	–	nA	Gross tested to 1 µA
C_{IN}	Capacitive load on pins as input	0.5	1.7	5	pF	Package and pin dependent Temperature = 25 °C
C_{OUT}	Capacitive load on pins as output	0.5	1.7	5	pF	Package and pin dependent Temperature = 25 °C

DC Programming Specifications

Table 17 lists the guaranteed minimum and maximum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and –40 °C ≤ T_A ≤ 85 °C, 3.0 V to 3.6 V and –40 °C ≤ T_A ≤ 85 °C, or 2.4 V to 3.0 V and –40 °C ≤ T_A ≤ 85 °C, respectively. Typical parameters apply to 5 V, 3.3 V, or 2.7 V at 25 °C. These are for design guidance only. Flash endurance and retention specifications with the use of the EEPROM User Module are valid only within the range: 25 °C +/–20C during the Flash Write operation. Reference the EEPROM User Module datasheet instructions for EEPROM flash write requirements outside of the 25 °C +/–20 °C temperature window.

Table 17. DC Programming Specifications

Symbol	Description	Min	Typ	Max	Units	Notes
V_{DDP}	V_{DD} for programming and erase	4.5	5	5.5	V	This specification applies to the functional requirements of external programmer tools
V_{DDLV}	Low V_{DD} for verify	2.4	2.5	2.6	V	This specification applies to the functional requirements of external programmer tools
V_{DDHV}	High V_{DD} for verify	5.1	5.2	5.3	V	This specification applies to the functional requirements of external programmer tools
$V_{DDIWRITE}$	Supply voltage for flash write operation	2.7	–	5.25	V	This specification applies to this device when it is executing internal flash writes
I_{DDP}	Supply current during programming or verify	–	5	25	mA	
V_{ILP}	Input low voltage during programming or verify	–	–	0.8	V	
V_{IHP}	Input high voltage during programming or verify	2.2	–	–	V	
I_{ILP}	Input current when applying V_{ILP} to P1[0] or P1[1] during programming or verify	–	–	0.2	mA	Driving internal pull-down resistor.
I_{IHP}	Input current when applying V_{IHP} to P1[0] or P1[1] during programming or verify	–	–	1.5	mA	Driving internal pull-down resistor.
V_{OLV}	Output low voltage during programming or verify	–	–	V_{SS} + 0.75	V	
V_{OHV}	Output high voltage during programming or verify	V_{DD} – 1.0	–	V_{DD}	V	
$Flash_{ENPB}$	Flash endurance (per block)	50,000[21]	–	–	–	Erase/write cycles per block.
$Flash_{ENT}$	Flash endurance (total)[20]	1,800,000	–	–	–	Erase/write cycles.
$Flash_{DR}$	Flash data retention	10	–	–	Years	

Notes
20. A maximum of 36 × 50,000 block endurance cycles is allowed. This is balanced between operations on 36 × 1 blocks of 50,000 maximum cycles each, 36 × 2 blocks of 25,000 maximum cycles each, or 36 × 4 blocks of 12,500 maximum cycles each (to limit the total number of cycles to 36 × 50,000 and that no single block ever sees more than 50,000 cycles).
21. The 50,000 cycle flash endurance per block is only guaranteed if the flash is operating within one voltage range. Voltage ranges are 2.4 V to 3.0 V, 3.0 V to 3.6 V and 4.75 V to 5.25 V.

DC I²C Specifications

Table 18 lists the guaranteed minimum and maximum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and –40 °C ≤ T_A ≤ 85 °C, 3.0V to 3.6 V and –40 °C ≤ T_A ≤ 85 °C, or 2.4 V to 3.0 V and –40 °C ≤ T_A ≤ 85 °C, respectively. Typical parameters apply to 5 V, 3.3 V, or 2.7 V at 25 °C. These are for design guidance only. Flash endurance and retention specifications with the use of the EEPROM user module are valid only within the range: 25 °C +/–20C during the Flash Write operation. Reference the EEPROM User Module datasheet instructions for EEPROM flash Write requirements outside of the 25 °C +/–20 °C temperature window.

Table 18. DC I²C Specifications[22]

Symbol	Description	Min	Typ	Max	Units	Notes
V_{ILI2C}	Input low level	–	–	0.3 × V_{DD}	V	2.4 V ≤ V_{DD} ≤ 3.6 V
		–	–	0.25 × V_{DD}	V	4.75 V ≤ V_{DD} ≤ 5.25 V
V_{IHI2C}	Input high level	0.7 × V_{DD}	–	–	V	2.4 V ≤ V_{DD} ≤ 5.25 V

AC Electrical Characteristics

AC Chip Level Specifications

Table 19, Table 20, and Table 21 list the guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and –40 °C ≤ T_A ≤ 85 °C, 3.0 V to 3.6 V and –40 °C ≤ T_A ≤ 85 °C, or 2.4 V to 3.0 V and –40 °C ≤ T_A ≤ 85 °C respectively. Typical parameters apply to 5 V, 3.3 V, or 2.7 V at 25 °C. These are for design guidance only.

Table 19. 5-V and 3.3-V AC Chip-Level Specifications

Symbol	Description	Min	Typ	Max	Units	Notes
F_{CPU1}	CPU frequency (3.3 V nominal)	0.75	–	12.6	MHz	12 MHz only for SLIMO Mode = 0.
F_{32K1}	Internal low speed oscillator frequency	15	32	64	kHz	
F_{32K_U}	Internal low speed oscillator (ILO) untrimmed frequency	5	–	100	kHz	After a reset and before the M8C starts to run, the ILO is not trimmed. See the System Resets section of the PSoC Technical Reference Manual for details on this timing.
F_{IMO12}	Internal main oscillator stability for 12 MHz (commercial temperature)[23]	11.4	12	12.6	MHz	Trimmed for 3.3 V operation using factory trim values. See Figure 11 on page 19, SLIMO mode = 0.
F_{IMO6}	Internal main oscillator stability for 6 MHz (commercial temperature)	5.5	6.0	6.5	MHz	Trimmed for 3.3 V operation using factory trim values. See Figure 11 on page 19, SLIMO mode = 1.
DC_{IMO}	Duty cycle of IMO	40	50	60	%	
DC_{ILO}	Internal low speed oscillator duty cycle	20	50	80	%	
t_{XRST}	External reset pulse width	10	–	–	µs	
$t_{POWERUP}$	Time from end of POR to CPU executing code	–	16	100	ms	Power-up from 0 V. See the System Resets section of the PSoC Technical Reference Manual.
SR_{POWER_UP}	Power supply slew rate	–	–	250	V/ms	
t_{jit_IMO} [24]	12 MHz IMO cycle-to-cycle jitter (RMS)	–	200	1600	ps	
	12 MHz IMO long term N cycle-to-cycle jitter (RMS)	–	600	1400	ps	N = 32
	12 MHz IMO period jitter (RMS)	–	100	900	ps	

Notes
22. All GPIO meet the DC GPIO V_{IL} and V_{IH} specifications found in the DC GPIO Specifications sections. The I²C GPIO pins also meet the above specs.
23. 0 to 70 °C ambient, V_{DD} = 3.3 V.
24. Refer to Cypress Jitter Specifications Application Note – AN5054 at http://www.cypress.com for more information.

AC External Clock Specifications

Table 24, Table 25, Table 26, and Table 27 list the guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and –40 °C ≤ T_A ≤ 85 °C, 3.0 V to 3.6 V and –40 °C ≤ T_A ≤ 85 °C, or 2.4 V to 3.0 V and –40 °C ≤ T_A ≤ 85 °C, respectively. Typical parameters apply to 5 V, 3.3 V, or 2.7 V at 25 °C. These are for design guidance only.

Table 24. 5-V AC External Clock Specifications

Symbol	Description	Min	Typ	Max	Units	Notes
F_{OSCEXT}	Frequency	0.750	–	12.6	MHz	
–	High period	38	–	5300	ns	
–	Low period	38	–	–	ns	
–	Power-up IMO to switch	150	–	–	µs	

Table 25. 3.3-V AC External Clock Specifications

Symbol	Description	Min	Typ	Max	Units	Notes
F_{OSCEXT}	Frequency with CPU clock divide by 1	0.750	–	12.6	MHz	Maximum CPU frequency is 12 MHz at 3.3 V. With the CPU clock divider set to 1, the external clock must adhere to the maximum frequency and duty cycle requirements.
–	High period with CPU clock divide by 1	41.7	–	5300	ns	
–	Low period with CPU clock divide by 1	41.7	–	–	ns	
–	Power-up IMO to switch	150	–	–	µs	

Table 26. 2.7-V (Nominal) AC External Clock Specifications

Symbol	Description	Min	Typ	Max	Units	Notes
F_{OSCEXT}	Frequency with CPU clock divide by 1	0.750	–	3.08	MHz	Maximum CPU frequency is 3 MHz at 2.7 V. With the CPU clock divider set to 1, the external clock must adhere to the maximum frequency and duty cycle requirements.
F_{OSCEXT}	Frequency with CPU clock divide by 2 or greater	0.15	–	6.35	MHz	If the frequency of the external clock is greater than 3 MHz, the CPU clock divider is set to 2 or greater. In this case, the CPU clock divider ensures that the fifty percent duty cycle requirement is met.
–	High period with CPU clock divide by 1	160	–	5300	ns	
–	Low period with CPU clock divide by 1	160	–	–	ns	
–	Power-up IMO to switch	150	–	–	µs	

Table 27. 2.7-V (Minimum) AC External Clock Specifications

Symbol	Description	Min	Typ	Max	Units	Notes
F_{OSCEXT}	Frequency with CPU clock divide by 1	0.750	–	6.3	MHz	Maximum CPU frequency is 6 MHz at 2.7 V. With the CPU clock divider set to 1, the external clock must adhere to the maximum frequency and duty cycle requirements.
F_{OSCEXT}	Frequency with CPU clock divide by 2 or greater	0.15	–	12.6	MHz	If the frequency of the external clock is greater than 6 MHz, the CPU clock divider is set to 2 or greater. In this case, the CPU clock divider ensures that the fifty percent duty cycle requirement is met.
–	High period with CPU clock divide by 1	160	–	5300	ns	
–	Low period with CPU clock divide by 1	160	–	–	ns	
–	Power-up IMO to switch	150	–	–	µs	

AC SPI Specifications

Table 31 and Table 32 list the guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and –40 °C ≤ T_A ≤ 85 °C, 3.0 V to 3.6 V and –40 °C ≤ T_A ≤ 85 °C, or 2.4 V to 3.0 V and –40 °C ≤ T_A ≤ 85 °C respectively. Typical parameters apply to 5 V, 3.3 V, or 2.7 V at 25 °C. These are for design guidance only.

Table 31. SPI Master AC Specifications

Symbol	Parameter	Conditions	Min	Typ	Max	Units
F_{SCLK}	SCLK clock frequency	–	–	–	12	MHz
DC_{SCLK}	SCLK duty cycle	–	–	50	–	%
t_{SETUP}	MISO to SCLK setup time	–	40	–	–	ns
t_{HOLD}	SCLK to MISO hold time	–	40	–	–	ns
t_{OUT_VAL}	SCLK to MOSI valid time	–	–	–	40	ns
t_{OUT_H}	MOSI high time	–	40	–	–	ns

Table 32. SPI Slave AC Specifications

Symbol	Parameter	Conditions	Min	Typ	Max	Units
F_{SCLK}	SCLK clock frequency	–	–	–	4	MHz
t_{LOW}	SCLK low time	–	41.67	–	–	ns
t_{HIGH}	SCLK high time	–	41.67	–	–	ns
t_{SETUP}	MOSI to SCLK setup time	–	30	–	–	ns
t_{HOLD}	SCLK to MOSI hold time	–	50	–	–	ns
t_{SS_MISO}	SS low to MISO valid	–	–	–	153	ns
t_{SCLK_MISO}	SCLK to MISO valid	–	–	–	125	ns
t_{SS_HIGH}	SS high time	–	50	–	–	ns
t_{SS_SCLK}	Time from SS low to first SCLK	–	$2/F_{SCLK}$	–	–	ns
t_{SCLK_SS}	Time from last SCLK to SS high	–	$2/F_{SCLK}$	–	–	ns

Packaging Dimensions

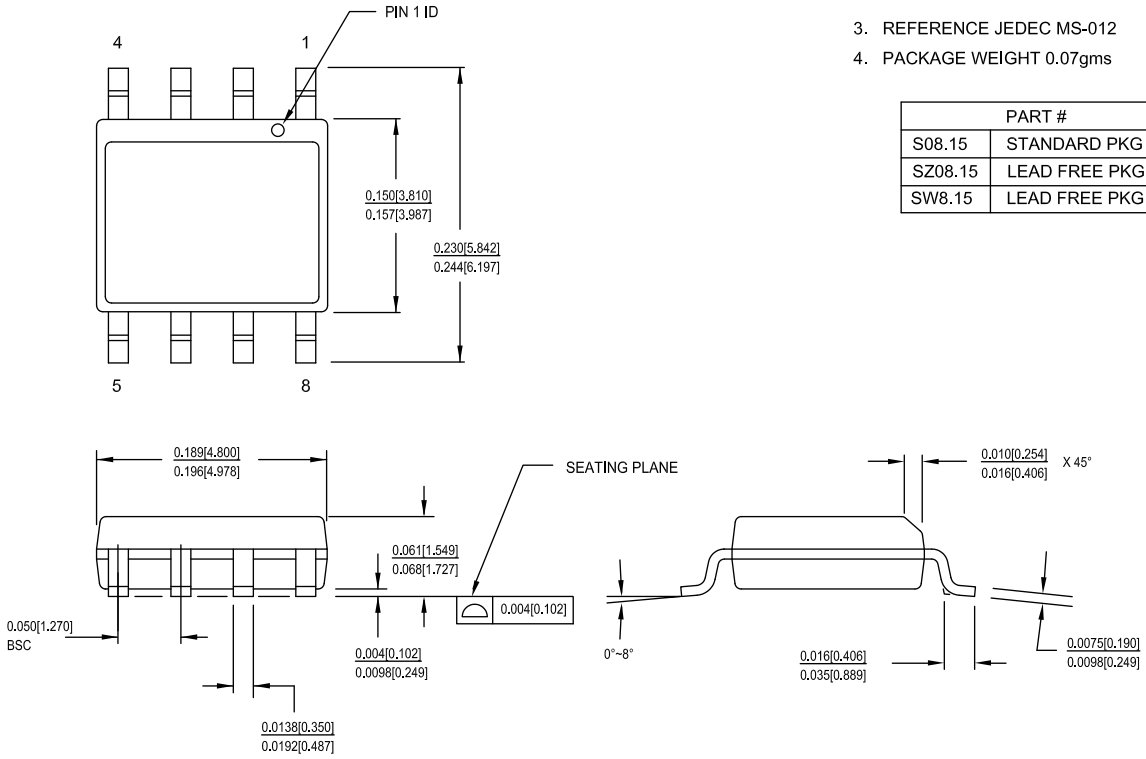
This section illustrates the packaging specifications for the CY8C20234, CY8C20334, CY8C20434, CY8C20534, and CY8C20634 PSoC devices along with the thermal impedances for each package.

Important Note Emulation tools may require a larger area on the target PCB than the chip's footprint. For a detailed description of the emulation tools' dimensions, refer to the emulator pod drawings at http://www.cypress.com.

Figure 14. 8-pin SOIC (150 Mils)

1. DIMENSIONS IN INCHES[MM] MIN.
   MAX.
2. PIN 1 ID IS OPTIONAL,
   ROUND ON SINGLE LEADFRAME
   RECTANGULAR ON MATRIX LEADFRAME
3. REFERENCE JEDEC MS-012
4. PACKAGE WEIGHT 0.07gms

PART #	
S08.15	STANDARD PKG
SZ08.15	LEAD FREE PKG
SW8.15	LEAD FREE PKG



51-85066 *G

Acronyms

Acronyms Used

Table 37 lists the acronyms that are used in this document.

Table 37. Acronyms Used in this Datasheet

Acronym	Description	Acronym	Description
AC	alternating current	MIPS	million instructions per second
ADC	analog-to-digital converter	OCD	on-chip debug
API	application programming interface	PCB	printed circuit board
CMOS	complementary metal oxide semiconductor	PGA	programmable gain amplifier
CPU	central processing unit	POR	power on reset
EEPROM	electrically erasable programmable read-only memory	PPOR	precision power on reset
GPIO	general purpose I/O	PSoC®	Programmable System-on-Chip
ICE	in-circuit emulator	PWM	pulse width modulator
IDAC	current DAC	QFN	quad flat no leads
IDE	integrated development environment	SLIMO	slow IMO
ILO	internal low speed oscillator	SPI™	serial peripheral interface
IMO	internal main oscillator	SRAM	static random access memory
I/O	input/output	SROM	supervisory read only memory
ISSP	in-system serial programming	SSOP	shrink small-outline package
LCD	liquid crystal display	USB	universal serial bus
LDO		WDT	watchdog timer
LED	light-emitting diode	WLCSP	wafer level chip scale package
LVD	low voltage detect	XRES	external reset
MCU	microcontroller unit		

Reference Documents

PSoC® CY8C20x34 and PSoC® CY8C20x24 Technical Reference Manual (TRM) – 001-13033

Design Aids – Reading and Writing PSoC® Flash - AN2015 (001-40459)

Design Guidelines for Cypress Quad Flat No Extended Lead (QFN) Packaged Devices – AN72845 available at http://www.cypress.com.

Document Conventions

Units of Measure

Table 38 lists the unit sof measures.

Table 38. Units of Measure

Symbol	Unit of Measure	Symbol	Unit of Measure
°C	degree Celsius	ms	millisecond
pF	picofarad	ns	nanosecond
kHz	kilohertz	ps	picosecond
MHz	megahertz	µV	microvolts
kΩ	kilohm	mV	millivolts
Ω	ohm	V	volts
µA	microampere	W	watt
mA	milliampere	mm	millimeter
nA	nanoampere	%	percent
µs	microsecond		

Numeric Conventions

Hexadecimal numbers are represented with all letters in uppercase with an appended lowercase ‘h’ (for example, ‘14h’ or ‘3Ah’). Hexadecimal numbers may also be represented by a ‘0x’ prefix, the C coding convention. Binary numbers have an appended lowercase ‘b’ (for example, 01010100b’ or ‘01000011b’). Numbers not indicated by an ‘h’ or ‘b’ are decimals.

Glossary

active high	1. A logic signal having its asserted state as the logic 1 state. 2. A logic signal having the logic 1 state as the higher voltage of the two states.
analog blocks	The basic programmable opamp circuits. These are SC (switched capacitor) and CT (continuous time) blocks. These blocks can be interconnected to provide ADCs, DACs, multi-pole filters, gain stages, and much more.
analog-to-digital (ADC)	A device that changes an analog signal to a digital signal of corresponding magnitude. Typically, an ADC converts a voltage to a digital number. The digital-to-analog (DAC) converter performs the reverse operation.
Application programming interface (API)	A series of software routines that comprise an interface between a computer application and lower level services and functions (for example, user modules and libraries). APIs serve as building blocks for programmers that create software applications.
asynchronous	A signal whose data is acknowledged or acted upon immediately, irrespective of any clock signal.
Bandgap reference	A stable voltage reference design that matches the positive temperature coefficient of VT with the negative temperature coefficient of VBE, to produce a zero temperature coefficient (ideally) reference.
bandwidth	1. The frequency range of a message or information processing system measured in hertz. 2. The width of the spectral region over which an amplifier (or absorber) has substantial gain (or loss); it is sometimes represented more specifically as, for example, full width at half maximum.
bias	1. A systematic deviation of a value from a reference value. 2. The amount by which the average of a set of values departs from a reference value. 3. The electrical, mechanical, magnetic, or other force (field) applied to a device to establish a reference level to operate the device.

Glossary

block	1. A functional unit that performs a single function, such as an oscillator. 2. A functional unit that may be configured to perform one of several functions, such as a digital PSoC block or an analog PSoC block.
buffer	1. A storage area for data that is used to compensate for a speed difference, when transferring data from one device to another. Usually refers to an area reserved for IO operations, into which data is read, or from which data is written. 2. A portion of memory set aside to store data, often before it is sent to an external device or as it is received from an external device. 3. An amplifier used to lower the output impedance of a system.
bus	1. A named connection of nets. Bundling nets together in a bus makes it easier to route nets with similar routing patterns. 2. A set of signals performing a common function and carrying similar data. Typically represented using vector notation; for example, address[7:0]. 3. One or more conductors that serve as a common connection for a group of related devices.
clock	The device that generates a periodic signal with a fixed frequency and duty cycle. A clock is sometimes used to synchronize different logic blocks.
comparator	An electronic circuit that produces an output voltage or current whenever two input levels simultaneously satisfy predetermined amplitude requirements.
compiler	A program that translates a high level language, such as C, into machine language.
configuration space	In PSoC devices, the register space accessed when the XIO bit, in the CPU_F register, is set to ‘1’.
crystal oscillator	An oscillator in which the frequency is controlled by a piezoelectric crystal. Typically a piezoelectric crystal is less sensitive to ambient temperature than other circuit components.
cyclic redundancy check (CRC)	A calculation used to detect errors in data communications, typically performed using a linear feedback shift register. Similar calculations may be used for a variety of other purposes such as data compression.
data bus	A bi-directional set of signals used by a computer to convey information from a memory location to the central processing unit and vice versa. More generally, a set of signals used to convey data between digital functions.
debugger	A hardware and software system that allows you to analyze the operation of the system under development. A debugger usually allows the developer to step through the firmware one step at a time, set break points, and analyze memory.
dead band	A period of time when neither of two or more signals are in their active state or in transition.
digital blocks	The 8-bit logic blocks that can act as a counter, timer, serial receiver, serial transmitter, CRC generator, pseudo-random number generator, or SPI.
digital-to-analog (DAC)	A device that changes a digital signal to an analog signal of corresponding magnitude. The analog-to-digital (ADC) converter performs the reverse operation.
duty cycle	The relationship of a clock period high time to its low time, expressed as a percent.
emulator	Duplicates (provides an emulation of) the functions of one system with a different system, so that the second system appears to behave like the first system.

Document History Page

Document Title: CY8C20134/CY8C20234/CY8C20334/CY8C20434/CY8C20534/CY8C20634, PSoC® Programmable System-on-Chip™ Document Number: 001-05356				
Revision	**ECN**	**Orig. of Change**	**Submission Date**	**Description of Change**
**	404571	HMT	See ECN	New silicon and document (Revision **).
*A	418513	HMT	See ECN	Updated Electrical Specifications, including Storage Temperature and Maximum Input Clock Frequency. Updated Features and Analog System Overview. Modified 32-pin QFN E-PAD dimensions. Added new 32-pin QFN. Add High Output Drive indicator to all P1[x] pinouts. Updated trademarks.
*B	490071	HMT	See ECN	Made datasheet “Final”. Added new Development Tool section. Added OCD pinout and package diagram. Added 16-pin QFN. Updated 24-pin and 32-pin QFN package diagrams to 0.60 max thickness. Changed from commercial to industrial temperature range. Updated Storage Temperature specification and notes. Updated thermal resistance data. Added development tool kit part numbers. Finetuned features and electrical specifications.
*C	788177	HMT	See ECN	Added CapSense SNR requirement reference. Added Low Power Comparator (LPC) AC/DC electrical specifications tables. Added 2.7V minimum specifications. Updated figure standards. Updated Technical Training paragraph. Added QFN package clarifications and dimensions. Updated ECN-ed Amkor dimensioned QFN package diagram revisions.
*D	1356805	HMT / SFVTMP3 / HCL / SFV	See ECN	Updated 24-pin QFN Theta JA. Added External Reset Pulse Width, TXRST, specification. Fixed 48-pin QFN.vsd. Updated the table introduction and high output voltage description in section two. The sentence: "Exceeding maximum ratings may shorten the battery life of the device.” does not apply to all datasheets. Therefore, the word "battery" is changed to "useful.” Took out tabs after table and figure numbers in titles and added two hard spaces. Updated the section, DC GPIO Specifications on page 20 with new text. Updated VOH5 and VOH6 to say, ”High Output Voltage, Port 1 Pins with 3.0V LDO Regulator Enabled.” Updated VOH7 and VOH8 with the text, “maximum of 20 mA source current in all I/Os.”Added 28-pin SSOP part, pinout, package. Updated specs. Modified dev. tool part numbers.
*E	2197347	UVS / AESA	See ECN	Added 32-pin Sawn QFN Pin diagram Removed package diagram: 32-Pin (5 × 5 mm) SAWN QFN(001-42168 *A) Updated Ordering Information table with CY8C20434-12LQXI and CY8C20434-12LQXIT ordering details. Corrected Table 16. DC Programming Specifications - Included above the table "Flash Endurance and Retention specifications with the use of the EEPROM User Module are valid only within the range: 25 °C +/-20C during the Flash Write operation. Refer the EEPROM User Module datasheet instructions for EEPROM Flash Write requirements outside of the 25 °C +/-20 °C temperature window."
*F	2542938	RLRM / AESA	07/30/2008	Corrected Ordering Information format. Updated package diagrams 001-13937 and 001-30999. Updated datasheet template. Corrected Figure 6 (28-pin diagram).
*G	2610469	SNV / PYRS	11/20/08	Updated V_{OH5}, V_{OH7}, and V_{OH9} specifications
*H	2693024	DPT / PYRS	04/16/2009	Changed title from PSoC® Mixed Signal Array to PSoC® Programmable System-on-Chip™ Replaced package outline drawing for 32-Pin Sawn QFN Updated “Development Tool Selection” on page 38 Updated “Development Tools” on page 7 and “Designing with PSoC Designer” on page 8 Updated “Getting Started” on page 6

Document History Page

Document Title: CY8C20134/CY8C20234/CY8C20334/CY8C20434/CY8C20534/CY8C20634, PSoC® Programmable System-on-Chip™ Document Number: 001-05356				
Revision	**ECN**	**Orig. of Change**	**Submission Date**	**Description of Change**
*I	2717566	DRSW / AESA	06/11/2009	Updated AC Chip-Level, and AC Programming Specifications as follows: Modified F_{IMO6} (page 20), T_{WRITE} specifications (page 23) Added I_{OH}, I_{OL} (page 17), Flash endurance note (page 19), DCILO (page 20), F32K_U (page 20), $T_{POWERUP}$ (page 20), $T_{ERASEALL}$ (page 23), $T_{PROGRAM\_HOT}$ (page 24), and $T_{PROGRAM\_COLD}$ (page 24) specifications Added AC SPI Master and Slave Specifications Added 30-Ball WLCSP Package
*J	2825336	ISW	12/10/2009	Updated pin description table for 48-pin OCD. Updated Ordering information table to include CY8C20534-12PVXA parts. Updated package diagrams for 48-pin QFN, 16-pin QFN (sawn), 24-pin QFN (sawn), and 30-ball WLCSP specs.
*K	2892629	NJF	03/15/2010	Updated Programmable pin configuration details in Features. Updated Analog Multiplexer System. Updated Cypress website links. Updated PSoC Designer Software Subsystems. Added $T_{BAKETEMP}$ and $T_{BAKETIME}$ parameters in Absolute Maximum Ratings. Removed the following sections: DC Low Power Comparator Specifications, AC Analog Mux Bus Specifications, AC Low Power Comparator Specifications, Third Party Tools, and Build a PSoC Emulator into your Board. Modified Notes in Packaging Dimensions. Updated Ordering Code Definitions. Removed inactive parts from Ordering Information. Updated links in Sales, Solutions, and Legal Information.
*L	2872902	VMAD	04/06/2010	Added part number CY8C20134 to the title. Added 8-pin and 16-pin SOIC pin and package details. Updated content to match current style guide and datasheet template. Moved acronyms and units of measure tables to page 35.
*M	3043170	NJF	09/30/2010	Added PSoC Device Characteristics table . Added DC I^2C Specifications table. Added F_{32K_U} max limit. Added Tjit_IMO specification, removed existing jitter specifications. Updated Units of Measure, Acronyms, Glossary, and References sections. Updated solder reflow specifications. No specific changed were made to I^2C Timing Diagram. Updated for clearer understanding. Template and styles update.
*N	3173718	NJF	02/16/2011	CY8C20134-12SX1I and CY8C20234-12SX2I typo error fixed in the ordering information table and changed in to CY8C20134-12SXI and CY8C20234-12SXI. Updated document version and date. Updated package diagram to 001-12919 *C.
*O	3248613	TOF	06/10/2011	Under Table 13, the text "Table 13 lists the guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and –40 °C ≤ T_A ≤ 85 °C, 3.0 V to 3.6 V and –40 °C ≤ T_A ≤ 85 °C, or 2.4 V to 3.0 V and –40 °C ≤ T_A ≤ 85 °C, respectively. Typical parameters apply to 5 V, 3.3 V, and 2.7 V at 25 °C. These are for design guidance only." changed to "Table 13 lists the guaranteed maximum and minimum specifications for the voltage and temperature ranges: 4.75 V to 5.25 V and –40 °C ≤ T_A ≤ 85 °C, 3.0 V to 3.6 V and –40 °C ≤ T_A ≤ 85 °C, or Table 14 for 2.4 V to 3.0 V and –40 °C ≤ T_A ≤ 85 °C, respectively. Typical parameters apply to 5 V, 3.3 V, and 2.7 V at 25 °C. These are for design guidance only". Updated Table 34 on page 37 table. Updated sections, "Getting Started", "Development Tools", and "Designing with PSoC Designer" to remove references to the system level designs. Updated package diagram 51-85066 to *E revision.
*P	3394775	KPOL	10/04/2011	Updated 16-pin SOIC and 16-pin QFN package drawings.